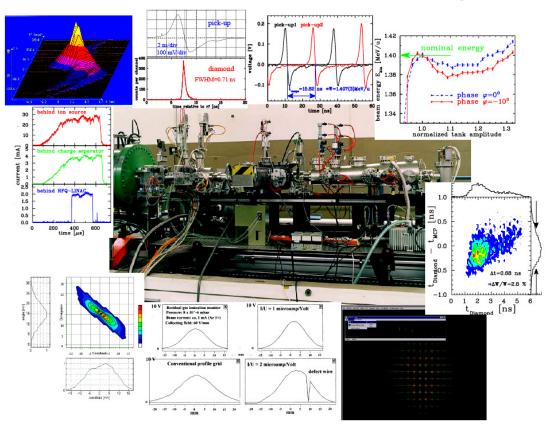


Beam Diagnostics and Instrumentation

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Demands on Beam Diagnostics



Diagnostics is the 'organ of sense' for the beam.

It deals with \underline{real} beams in \underline{real} technical installations including all imperfections.

Three types of demands leads to different installations:

- Quick, non-destructive measurements leading to a single number or simple plots.
 Used as a check for online information. Reliable technologies have to be used.
 Example: Current measurement by transformers.
- ➤ Instrumentation for daily check, malfunction diagnosis and wanted parameter variation.

 **Example: Profile measurement, in many cases 'intercepting' i.e destructive to the beam
- ➤ Complex instrumentation used for hard malfunction, commissioning and accelerator development.

The instrumentation might be destructive and complex.

Example: Emittance determination.

A clear interpretation of the results is a important design criterion.

Non-destructive ('non-intercepting') methods are preferred:

- > The beam is not influenced
- ➤ The instrument is not destroyed.

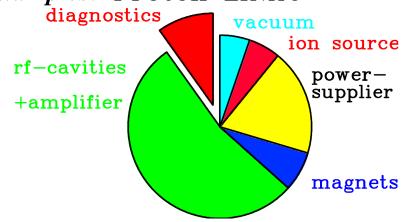
The Role of Beam Diagnostics



The cost of diagnostics is about 3 to 10 % of the total facility cost:

- $> \approx 3$ % for large accelerators *or* accelerators with standard technologies
- $\geq 10\%$ for versatile accelerators *or* novel accelerators and technologies.

Cost Examples: Proton LINAC



Super-conducting synchr.



The amount of man-power is about 10 to 20 %:

- > very different physics and technologies are applied
- technologies have to be up-graded, e.g. data acquisition and analysis
- > accelerator improvement calls for new diagnostic concepts.

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Relevant physical Processes for Beam Diagnostics



- > Electro-magnetic influence by moving charges:
 - → classical electro-dynamics, voltage and current meas., low and high frequencies Examples: Faraday cups, beam transformers, pick-ups
- **Emission of photon by accelerated charges: (only for relativistic electrons)**
 - → classical electro-dynamics, optical techniques (from visible to x-ray)

Example: Synchrotron radiation monitors

- **➤ Interaction of particles with photons:**
 - → optics, lasers, optical techniques, particle detectors

Examples: laser scanners, short bunch length measurement, polarimeters

- > Coulomb interaction of charged particles with matter:
- → atomic and solid state physics, current measurement, optics, particle detectors Examples: scintillators, viewing screens, ionization chambers, residual gas monitors
- **➤**Nuclear- or elementary particle physics interactions:
 - → nuclear physics, particle detectors

Examples: beam loss monitors, polarimeters, luminosity monitors

>And of cause accelerator physics for proper instrumentation layout.

Beam diagnostics deals with the full spectrum of physics and technology,

⇒ this calls for experts on all these fields and is a challenging task!

Beam Quantities and their Diagnostics I



LINAC & transport lines: Single pass ↔ **Synchrotron:** multi pass

Electrons: always relativistic \leftrightarrow **Protons/Ions:** non-relativistic for $E_{kin} < 1$ GeV/u

Depending on application: Low current ↔ high current

Overview of the most commonly used systems:

Beam quantity		LINAC & transfer line	Synchrotron
Current I	General	Transformer, dc & ac	Transformer, dc & ac
		Faraday Cup	
	Special	Particle Detectors	Pick-up Signal (relative)
Profile x _{width}	General	Screens, SEM-Grids	Residual Gas Monitor
,,		Wire Scanners, OTR Screen	Wire Scanner,
			Synchrotron Light Monitor
	Special	MWPC, Fluorescence Light	
Position x_{cm}	General	Pick-up (BPM)	Pick-up (BPM)
	Special	Using position measurement	
Transverse Emittance ε_{trans}	General	Slit-grid	Residual Gas Monitor
		Quadrupole Variation	Wire Scanner
	Special	Pepper-Pot	Transverse Schottky

Beam Quantities and their Diagnostics II

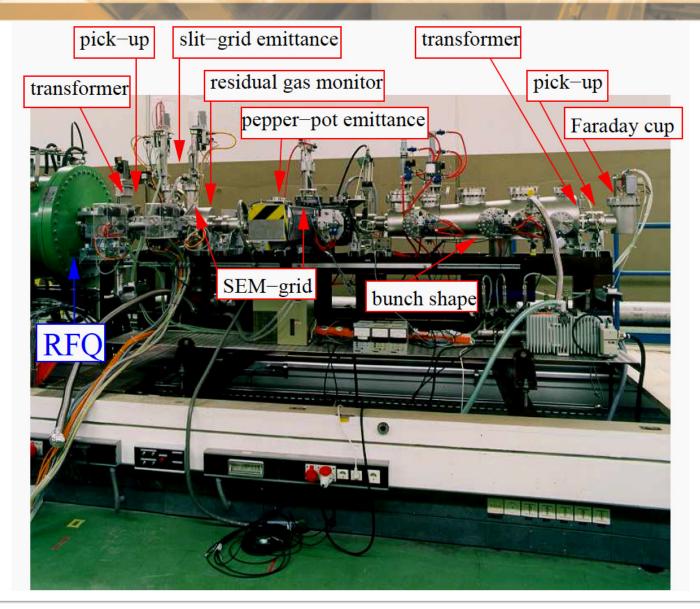


Beam quantity		LINAC & transfer line	Synchrotron
Bunch Length Δφ	General	Pick-up	Pick-up
			Wall Current Monitor
	Special	Secondary electrons	Streak Camera, Laser
Momentum p and	General	Pick-ups (Time-of-Flight)	Pick-up (e.g. tomography)
Momentum Spread <i>∆p/p</i>	Special	Magnetic Spectrometer	Schottky Noise Spectrum
Longitudinal Emittance ε_{long}	General	Buncher variation	
	Special	Magnetic Spectrometer	Pick-up & tomography
Tune and Chromaticity Q, ξ	General		Exciter + Pick-up
	Special		Transverse Schottky Spectrum
Beam Loss r _{loss}	General	Particle Detectors	
Polarization P	General	Particle Detectors	
	Special	Laser Scattering (Compton scattering)	
Luminocity L	General	Particle Detectors	

- ➤ Destructive and non-destructive devices depending on the beam parameter.
- ➤ Different techniques for the same quantity ↔ Same technique for the different quantities.

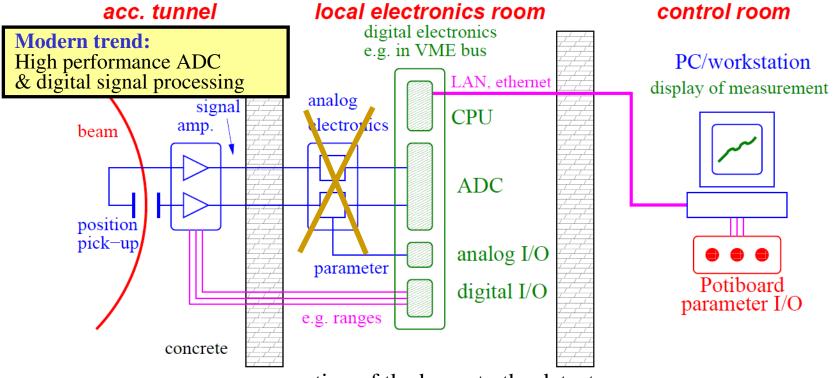
Example: Diagnostics Bench for the Commissioning of an RFQ





Typical Installation of a Diagnostics Device





accelerator tunnel:

- \rightarrow action of the beam to the detector
- → low noise pre-amplifier and first signal shaping
 - → analog treatment, partly combining other parameters
- local electronics room:
- → digitalization, data bus systems (GPIB, VME, cPCI...)

- control room:
- → visualization and storage on PC
- → parameter setting of the beam and the instruments

Example: Graphical User Interface for Beam Position Monitors





The result helps to align the accelerator!

Some experimental device parameters are also shown to prove the functionality.

Outline of the Lecture

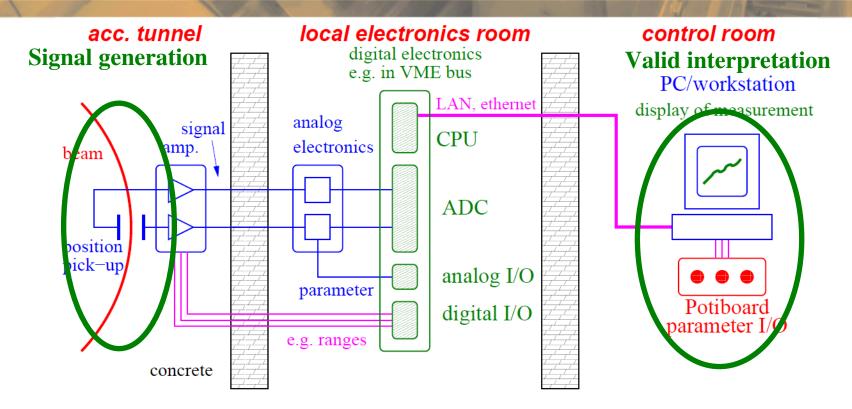


The ordering of the subjects is oriented by the beam quantities:

- **Current measurement:** Transformers, cups, particle detectors
- **Profile measurement:** Various methods depending on the beam properties
- ➤ Transverse emittance measurement: Destructive devices, determination by linear transformations
- ➤ Pick-ups for bunched beams: Principle and realization of rf pick-ups, closed orbit and tune measurements
- ➤ Measurement of longitudinal parameters: Beam energy with pick-ups, time structure of bunches for low and high beam energies, longitudinal emittance
- **Beam loss detection:** Secondary particle detection for optimization and protection
- It will be discussed: The action of the beam to the detector, the design of the devices, generated raw data, partly analog electronics, results of the measurements.
- It will not be discussed: Detailed signal-to-noise calculations, analog electronics, digital electronics, data acquisition and analysis, online and offline software....
- General: Standard methods and equipment for stable beams with moderate intensities.

Goal of the Lecture





The goal of the lecture should be:

- **➤** Understanding the signal generation of various device
- > Showing examples for real beam behavior
- > Enabling a correct interpretation of various measurements.

The Accelerator Facility at GSI



